

<b>Notice of References Cited</b>	Application/Control No. 10/588,125		Applicant(s)/Patent Under Reexamination OHGARU ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2006/0286313	12-2006	Fukagawa et al.	428/001.31
*	C	US-2007/0195226	08-2007	Aminaka et al.	349/096
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	K	US-			
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#### NON-PATENT DOCUMENTS

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